

TOSHIBA Transistor Silicon NPN Triple Diffused Type (Darlington Power Transistor)

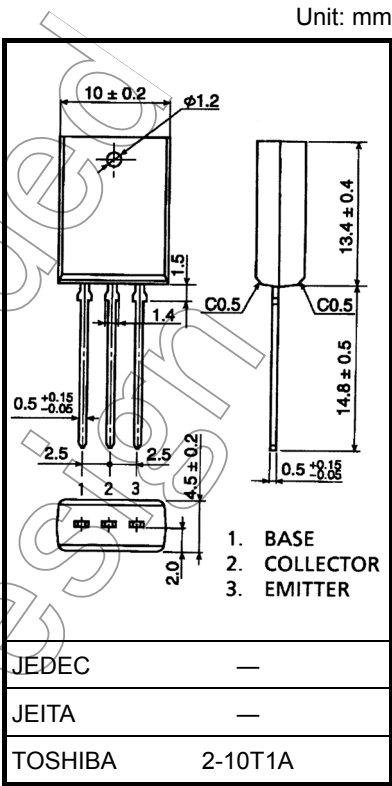
# 2SD2526

High Power Switching Applications  
Hammer Drive, Pulse Motor Drive Applications

- High DC current gain:  $h_{FE} = 2000$  (min) ( $V_{CE} = 3\text{ V}$ ,  $I_C = 3\text{ A}$ )
- Low saturation voltage:  $V_{CE(sat)} = 1.5\text{ V}$  (max) ( $I_C = 3\text{ A}$ )
- Complementary to 2SB1641

## Absolute Maximum Ratings ( $T_a = 25^\circ\text{C}$ )

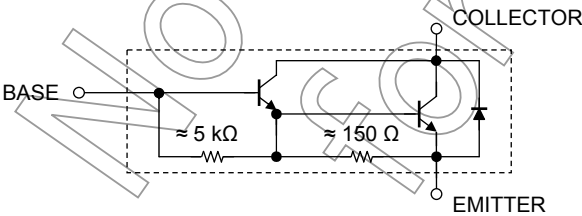
Characteristics		Symbol	Rating	Unit
Collector-base voltage		$V_{CBO}$	100	V
Collector-emitter voltage		$V_{CEO}$	100	V
Emitter-base voltage		$V_{EBO}$	7	V
Collector current	DC	$I_C$	5	A
	Pulse		8	
Base current		$I_B$	0.5	A
Collector power dissipation		$P_C$	1.8	W
Junction temperature		$T_j$	150	$^\circ\text{C}$
Storage temperature range		$T_{stg}$	-55 to 150	$^\circ\text{C}$



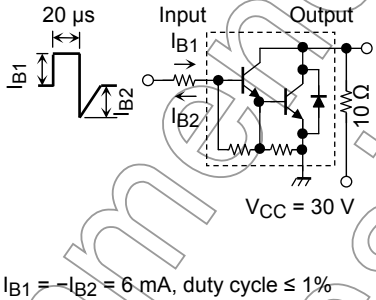
Weight: 1.5 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

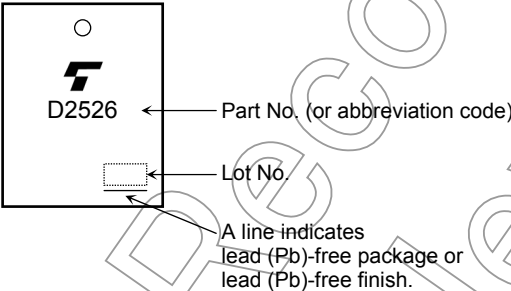
## Equivalent Circuit

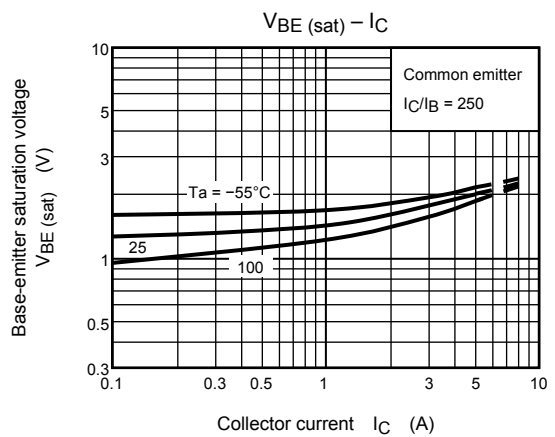
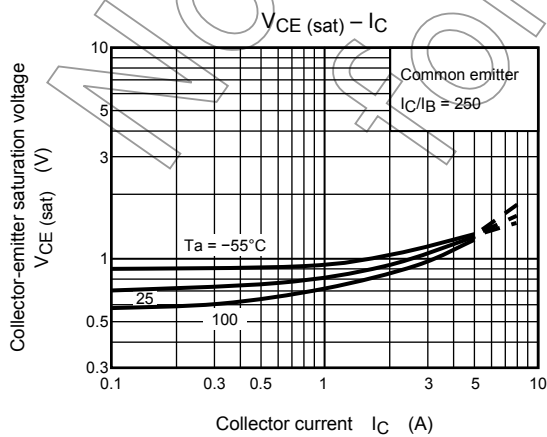
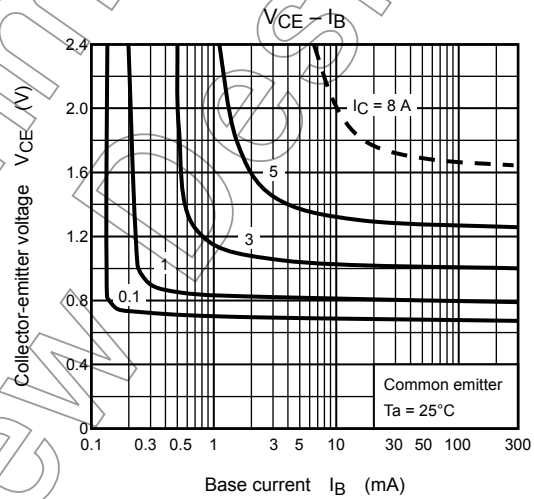
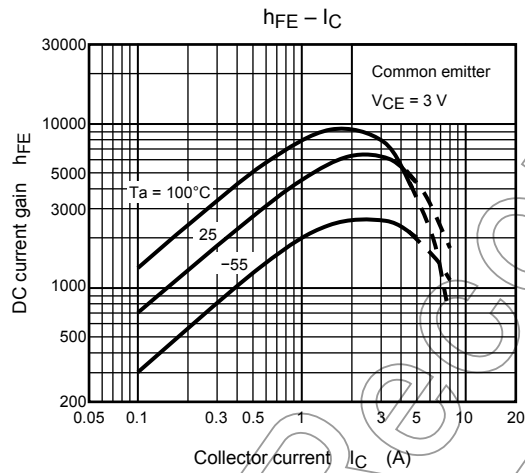
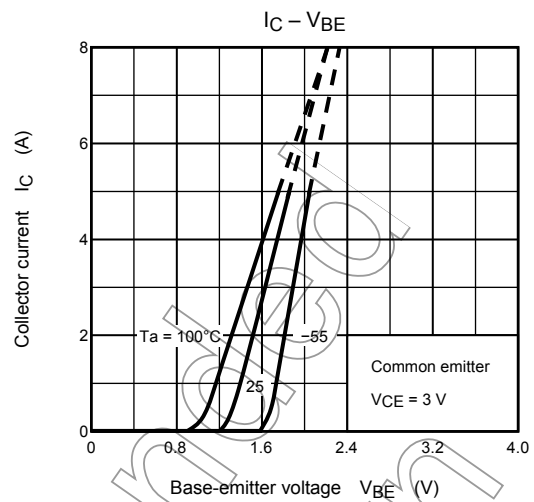
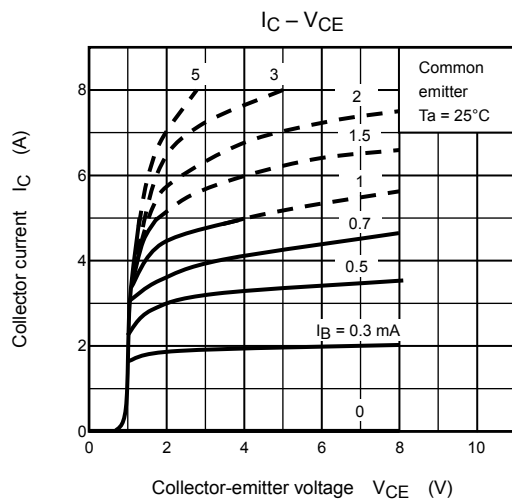


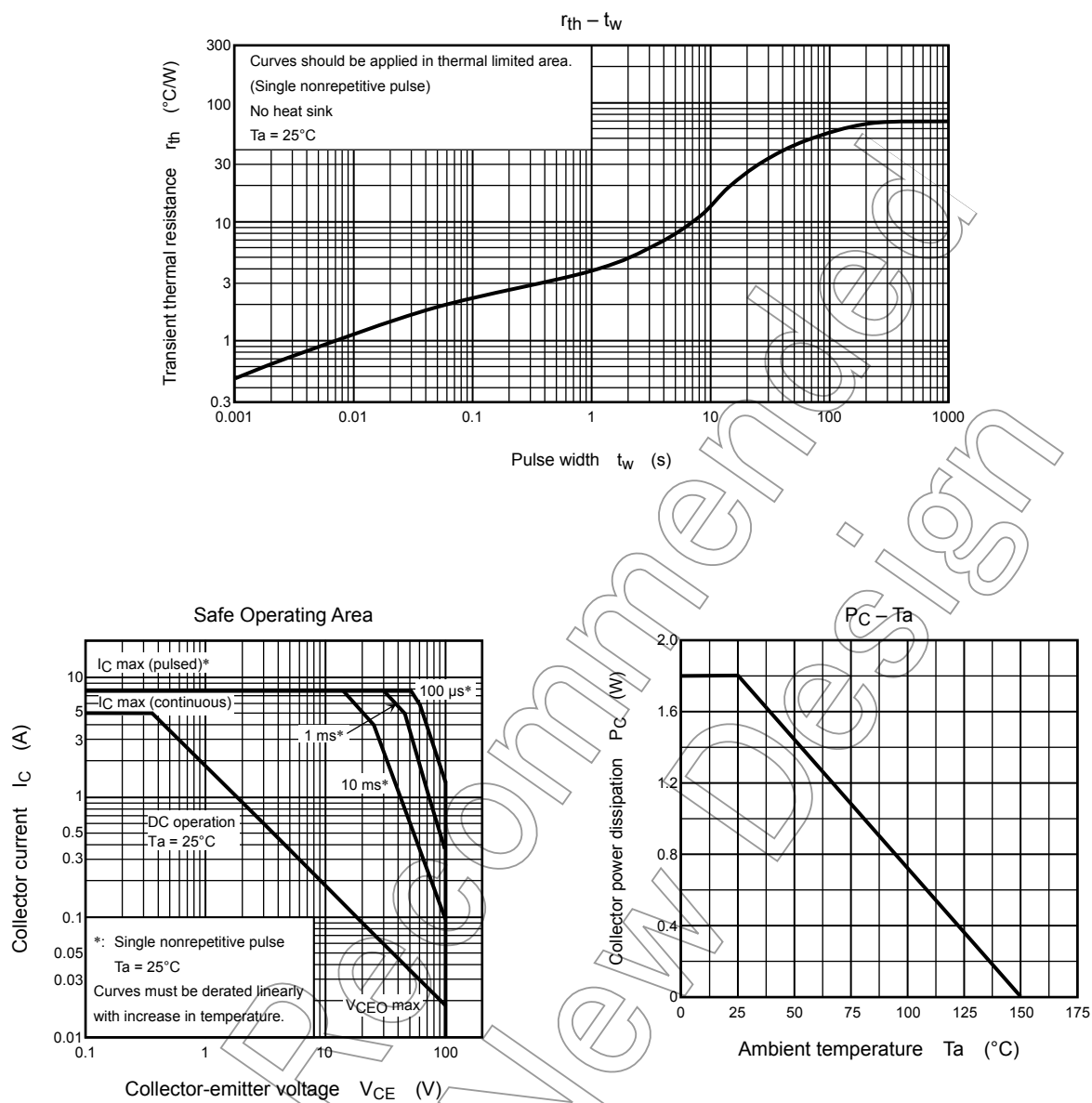
Electrical Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit
Collector cut-off current		ICBO	V <sub>CB</sub> = 100 V, I <sub>E</sub> = 0	—	—	100	μA
Emitter cut-off current		IEBO	V <sub>EB</sub> = 6 V, I <sub>C</sub> = 0	—	—	2.5	mA
Collector-emitter breakdown voltage		V (BR) CEO	I <sub>C</sub> = 30 mA, I <sub>B</sub> = 0	100	—	—	V
DC current gain	h <sub>FE</sub> (1)		V <sub>CE</sub> = 3 V, I <sub>C</sub> = 3 A	2000	—	15000	
	h <sub>FE</sub> (2)		V <sub>CE</sub> = 3 V, I <sub>C</sub> = 5 A	1000	—	—	
Collector-emitter saturation voltage	V <sub>CE</sub> (sat) (1)		I <sub>C</sub> = 3 A, I <sub>B</sub> = 6 mA	—	1.1	1.5	V
	V <sub>CE</sub> (sat) (2)		I <sub>C</sub> = 5 A, I <sub>B</sub> = 20 mA	—	1.3	2.5	
Base-emitter saturation voltage		V <sub>BE</sub> (sat)	I <sub>C</sub> = 3 A, I <sub>B</sub> = 6 mA	—	1.7	2.5	V
Switching time	Turn-on time	t <sub>on</sub>		—	1.0	—	μs
	Storage time	t <sub>stg</sub>		—	4.0	—	
	Fall time	t <sub>f</sub>		—	2.5	—	

Marking







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